

Lonten N-channel 100V, 360A, 1.55mΩ Power MOSFET

Description

These N-Channel enhancement mode power field effect transistors are using **shielded gate trench** DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and with stand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

Features

- $100V,360A,R_{DS(on)}.max=1.55m\Omega@VGS = 10V$
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green device available

Applications

- Motor Drives
- UPS
- DC-DC Converter
- Telecom
- Battery management

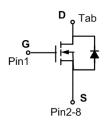
Product Summary

 $\begin{array}{ll} V_{DSS} & 100V \\ R_{DS(on).typ}@V_{GS}\text{=}10V & 1.2m\Omega \\ I_D & 360A \end{array}$

Pin Configuration



TOLL



N-Channel MOSFET



Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V _{DSS}	100	V
Continuous drain current ¹⁾ (T _C = 25°C ,Silicon limit)		416	Α
(T _C = 25°C, Package limit)	I _D	360	Α
(T _C = 100°C,Silicon limit)		263	Α
Pulsed drain current 2)	I _{DM}	1440	Α
Gate-Source voltage	V _{GSS}	±20	V
Avalanche energy 3)	E _{AS}	2056	mJ
Power Dissipation	P _D	481	W
Storage Temperature Range	T _{STG}	-55 to +150	°C
Operating Junction Temperature Range	TJ	-55 to +150	°C

Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	R _{eJC}	0.26	°C/W
Thermal Resistance, Junction-to-Ambient 4)	R _{θJA}	58.18	°C/W
Soldering temperature, wavesoldering only allowed	т	260	°C
at leads. (1.6mm from case for 10s)	sold		



Package Marking and Ordering Information

Device	Device Package	Marking	Units/Reel	
LSGT10R015	TOLL	LSGT10R015	2000	

Electrical Characteristics T_J = 25°C unless otherwise noted

Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Static characteristics	•		•			•
Drain-source breakdown voltage	BV _{DSS}	V _{GS} =0V, I _D =250uA	100			V
Gate threshold voltage	$V_{GS(th)}$	V _{DS} =V _{GS} , I _D =250uA	2.5		4.5	V
		V _{DS} =100V, V _{GS} =0V, T _J =25°C			1	μA
Drain-source leakage current	I _{DSS}	V _{DS} =100V, V _{GS} =0V, T _J =150°C			10	mA
Gate leakage current, Forward	I _{GSSF}	V _{GS} =20V, V _{DS} =0V			100	nA
Gate leakage current, Reverse	I _{GSSR}	V _{GS} =-20V, V _{DS} =0V			-100	nA
		V _{GS} =10 V, I _D =50 A,				
Drain-source on-state resistance	R _{DS(on)}	T _J =25°C		1.2	1.55 r	mΩ
		T _J =150°C		2.1		
Forward transconductance	g _{fs}	V _{DS} =5V , I _D =50A		150.9		S
Dynamic characteristics						
Input capacitance	C _{iss}	V 50 V V 0V		21761		
Output capacitance	Coss	V _{DS} =50 V, V _{GS} =0V,		4016		pF
Reverse transfer capacitance	C _{rss}	- f=100kHz		63		
Turn-on delay time	t _{d(on)}			224		ns
Rise time	t _r	V_{DD} =50V, V_{GS} =10V, I_{D} =50 A, R_{g} =10 Ω		179		
Turn-off delay time	t _{d(off)}			270		
Fall time	t _f			98		
Gate resistance	R_g	V _{GS} =0V, V _{DS} =0V, f=1MHz		1.5		Ω
Gate charge characteristics						•
Gate to source charge	Q_{gs}	\		100		
Gate to drain charge	Q_{gd}	V _{DS} =50V, I _D =50A,		55		nC
Gate charge total	Q_g	- V _{GS} =10V		293		
Gate plateau voltage	V _{plateau}			4.9		V
Output Charge	Q _{oss}	V _{DS} =50V,V _{GS} =0V		338		nC
Drain-Source diode characterist	ics and Maxir	num Ratings	1	•		•
Continuous Source Current	Is				360	Α
Pulsed Source Current	I _{SM}				1440	А
Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _S =50A, T _J =25℃			1.1	V
Reverse Recovery Time	t _{rr}	1 - FOA - 41/44-000A/ T - 05°0		79		ns
Reverse Recovery Charge	Q _{rr}	I _S =50A, di/dt=200A/us, T _J =25℃		361		nC

Notes:

- 1. Limited by maximum junction temperature and duty cycle.
- ${\it 2.} Repetitive\ Rating:\ Pulse\ width\ limited\ by\ maximum\ junction\ temperature.$
- 3. $V_{DD}\text{=}50\text{V},\,V_{GS}\text{=}10\text{V},\,L\text{=}0.5\text{mH},\,I_{AS}\text{=}90.7\text{A}$, Starting $T_J\text{=}25^{\circ}\!\!\text{C}$.
- 4. The value of R_{thJA} is measured by placing the device in a still air box which is one cubic foot.

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Electrical Characteristics Diagrams

Figure 1. Typ. Output Characteristics

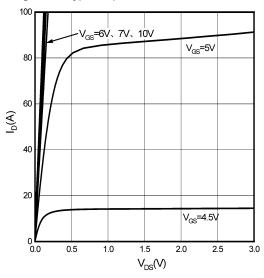


Figure 3. On-Resistance vs. Drain Current

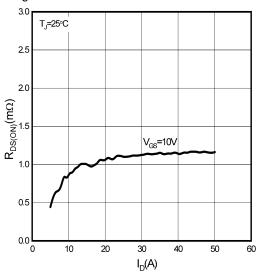


Figure 5.Breakdown Voltage vs.Temperature

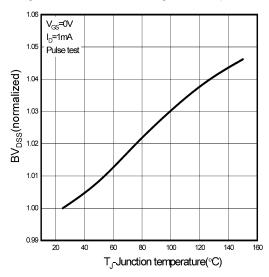


Figure 2. Transfer Characteristics

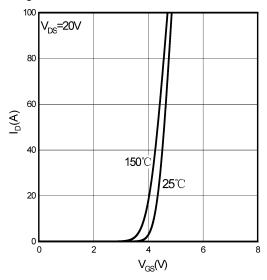


Figure 4.On-Resistance vs.Temperature

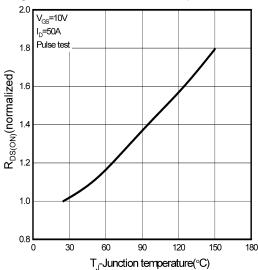


Figure 6.Threshold Voltage vs.Temperature

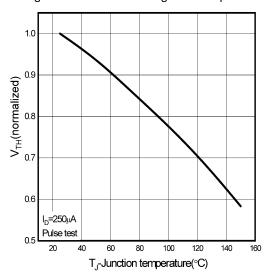




Figure 7.Rds(on) vs. Gate Voltage

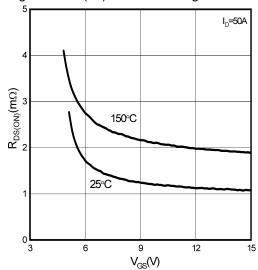


Figure 9. Capacitance Characteristics

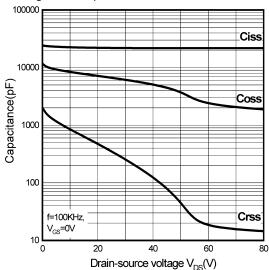


Figure 11.Drain Current Derating

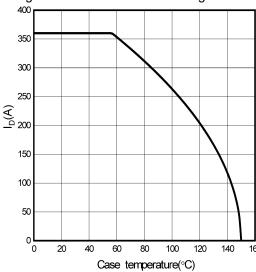


Figure 8.Body-Diode Characteristics

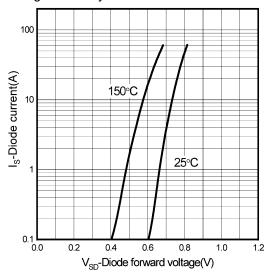


Figure 10.Gate Charge Characteristics

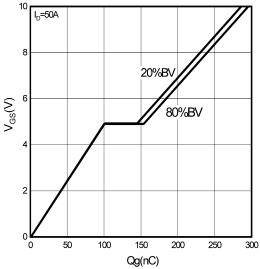
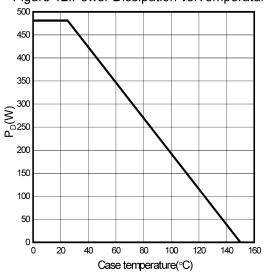


Figure 12. Power Dissipation vs. Temperature



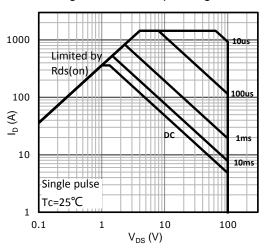
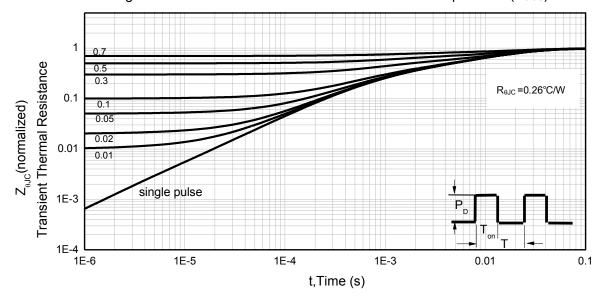


Figure 13. Safe Operating Area

Figure 14. Normalized Maximum Transient Thermal Impedance (RthJC)

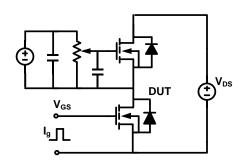


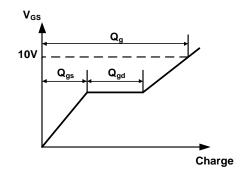
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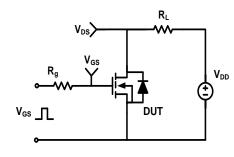
Test Circuit & Waveforms

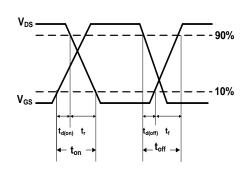
Gate Charge Test Circuit & Waveform



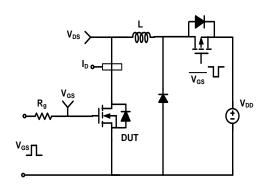


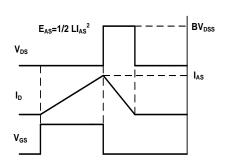
Resistive Switching Test Circuit & Waveform



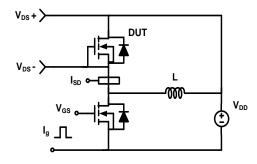


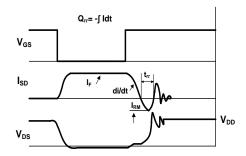
Unclamped Inductive Switching (UIS) Test Circuit & Waveform





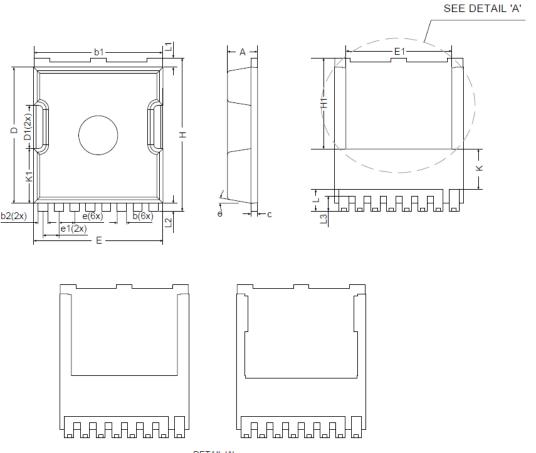
Diode Recovery Test Circuit & Waveform







Mechanical Dimensions for TOLL



DETAIL 'A' SCALE: 1/1

SYMBOLS	MILLIMETERS		INCHES	
SYMBOLS	MIN	MAX	MIN	MAX
Α	2.15	2.45	0.085	0.096
b	0.60	0.90	0.024	0.035
b1	9.65	9.95	0.380	0.392
b2	0.65	0.90	0.026	0.035
С	0.40	0.60	0.016	0.024
D	10.18	10.58	0.401	0.417
D1	3.15	3.45	0.124	0.136
Е	9.70	10.10	0.382	0.398
E1	7.90	8.40	0.311	0.331
е	1.10	1.30	0.043	0.051
e1	1.10	1.30	0.043	0.051
Н	11.48	11.88	0.452	0.468
H1	6.75	7.30	0.266	0.287
K	2.45	3.33	0.096	0.131
K1	4.03	4.33	0.159	0.170
L	1.50	2.10	0.059	0.083
L1	0.50	0.90	0.020	0.035
L2	0.45	0.75	0.018	0.030
L3	1.00	1.30	0.039	0.051
θ	10° REF		10° REF	



Revision History

LSGT10R015 Revision 1.3

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